

Notice of References Cited	Application/Control No. 10/501,928	Applicant(s)/Patent Under Reexamination HIRAI ET AL.	
	Examiner EDMUND H. LEE	Art Unit 1791	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,531,082	03-2003	Klee, Peter	264/257
*	C	US-6,069,430	05-2000	Tsunoda et al.	310/180
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	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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